

SEARCHED

Class	Sub.	Date	Exmr.
324	754	5/18/01	52
	755	5/18/01	
	765	5/19/01	
	762	5/21/01	
	158.1		
	758		
	757		

SEARCH NOTES

(INCLUDING SEARCH STRATEGY)

	Date	Exmr.
inspected app. # 08/821,468	5/18/01	TM
EAST	5/19/01	TM
"Fabricating interconnect semiconductor die"		
"Wafer 'opening'"		
"insulated #3 conductive"	↓	↓
08/821,468 checked references	2/7/02	TM

INTERFERENCE SEARCHED

[illegible]